

RoHS Compliant Product  
A suffix of "-C" specifies halogen and lead-free

## FEATURES

The SMG2007-C provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SC-59 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

## APPLICATIONS

- Simple Drive Requirement
- Lower On-resistance
- Fast Switching

## MARKING

2007

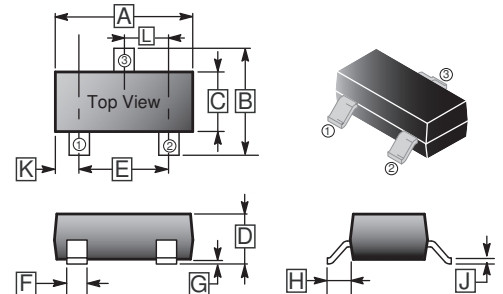
## PACKAGE INFORMATION

Package	MPQ	Leader Size
SC-59	3K	7 inch

## ORDER INFORMATION

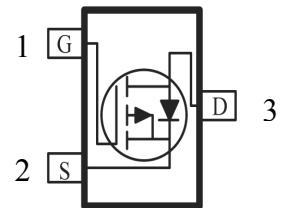
Part Number	Type
SMS2007-C	Lead (Pb)-free and Halogen-free

## SC-59



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0.10	REF.
B	2.10	3.00	H	0.40	REF.
C	1.20	1.70	J	0.047	0.207
D	0.89	1.40	K	0.5	REF.
E	2.00	Typ.	L	0.95	REF.
F	0.30	0.50			

## TOP VIEW



## ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	$V_{DS}$	-20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>1</sup> @ $V_{GS} = -4.5\text{V}$	$I_D$	$T_C=25^\circ\text{C}$	-7.2
		$T_C=100^\circ\text{C}$	-5
		$T_A=25^\circ\text{C}$	-4.7
		$T_A=70^\circ\text{C}$	-3.8
Pulsed Drain Current <sup>3</sup>	$I_{DM}$	-20	A
Power Dissipation	$P_D$	1.38	W
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~150	$^\circ\text{C}$
<b>Thermal Resistance Rating</b>			
Maximum Junction to Ambient <sup>1</sup>	$R_{\theta JA}$	$t \leq 5\text{sec}, 90$	$^\circ\text{C} / \text{W}$
		Steady State, 125	
Maximum Junction to Ambient <sup>2</sup>	$R_{\theta JA}$	270	
Thermal Resistance Junction to Case <sup>1</sup>	$R_{\theta JC}$	80	

**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ C$  unless otherwise specified)

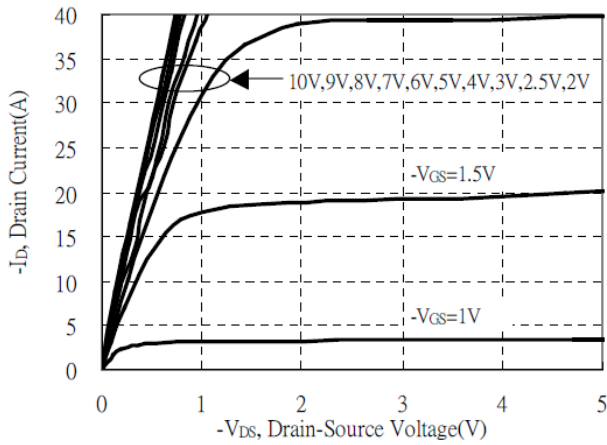
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$BV_{DSS}$	-20	-	-	V	$V_{GS}=0, I_D = -250\mu A$
Gate-Source Threshold Voltage	$V_{GS(th)}$	-0.3	-	-0.9	V	$V_{DS}=V_{GS}, I_D = -250\mu A$
Forward Transconductance	$g_{fs}$	-	19.1	-	S	$V_{DS} = -5V, I_D = -4.5A$
Gate-Body Leakage Current	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{DS}=0, V_{GS} = \pm 12V$
Drain-Source Leakage Current	$I_{DSS}$	-	-	-1	$\mu A$	$V_{DS} = -20V, V_{GS}=0, T_J = 25^\circ C$
		-	-	-5		$V_{DS} = -20V, V_{GS}=0, T_J = 55^\circ C$
Drain-Source On-Resistance	$R_{DS(ON)}$	-	-	19	m $\Omega$	$V_{GS} = -4.5V, I_D = -4A$
		-	-	25		$V_{GS} = -2.5V, I_D = -2A$
		-	-	30		$V_{GS} = -1.8V, I_D = -1A$
Total Gate Charge	$Q_g$	-	24.5	-	nC	$V_{DS} = -10V,$ $V_{GS} = -4.5V,$ $I_D = -4.5A$
Gate-Source Charge	$Q_{gs}$	-	2.9	-		
Gate-Drain Charge	$Q_{gd}$	-	4.9	-		
Turn-on Delay Time	$T_{d(on)}$	-	6.8	-	nS	$V_{DS} = -10V,$ $V_{GS} = -4.5V,$ $I_D = -1A,$ $R_G = 6\Omega,$ $R_L = 10\Omega$
Rise Time	$T_r$	-	26.6	-		
Turn-off Delay Time	$T_{d(off)}$	-	222.8	-		
Fall Time	$T_f$	-	115.4	-		
Input Capacitance	$C_{iss}$	-	2100	-	pF	$V_{DS} = -10V,$ $V_{GS} = 0,$ $f = 1.0MHz$
Output Capacitance	$C_{oss}$	-	213	-		
Reverse Transfer Capacitance	$C_{rss}$	-	166	-		
<b>Source-Drain Diode</b>						
Continuous Source Current <sup>1</sup>	$I_S$			-1.7	A	
Pulsed Source Current <sup>3</sup>	$I_{SM}$			-10	A	
Forward On Voltage <sup>4</sup>	$V_{SD}$	-	-	-1.2	V	$I_S = -1.7A, V_{GS} = 0V$
Reverse Recovery Time	$T_{rr}$	-	67.5	-	ns	$I_S = -1.7A, V_{GS} = 0V$
Reverse Recovery Charge	$Q_{rr}$	-	51.6	-	nC	$di/dt = 100A/\mu s$

Notes:

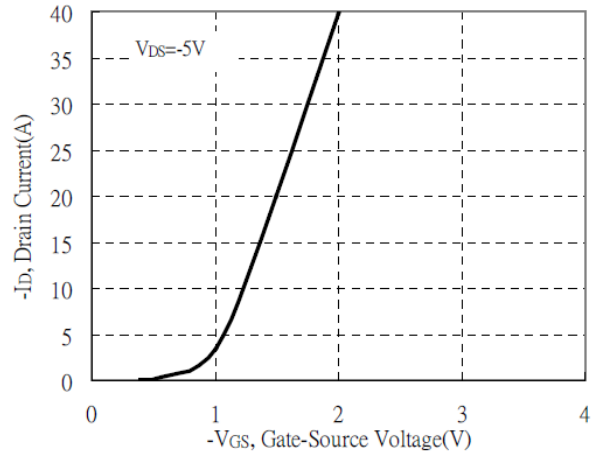
1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.
2. When mounted on Min. copper pad.
3. Pulse width limited by maximum junction temperature , Pulse Width  $\leq 300\mu s$ , Duty Cycles  $\leq 2\%$ .
4. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$

**CHARACTERISTIC CURVES**

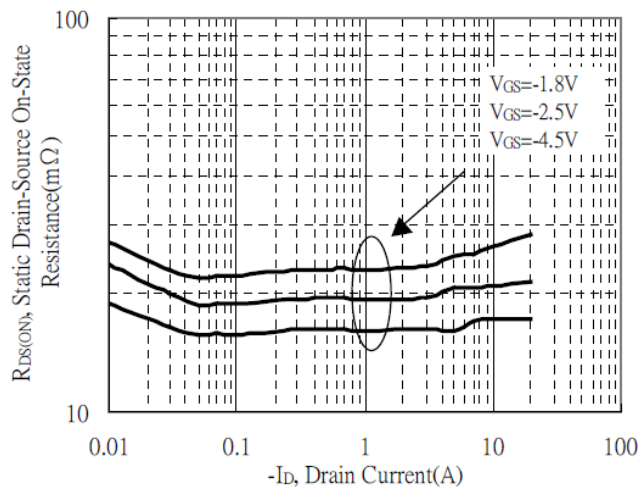
Typical Output Characteristics



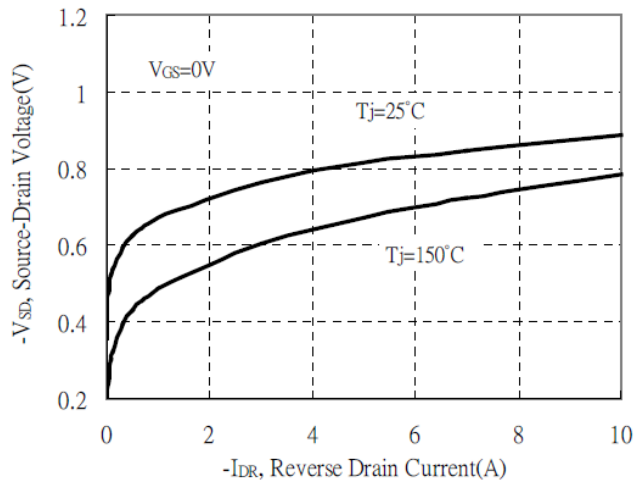
Typical Transfer Characteristics



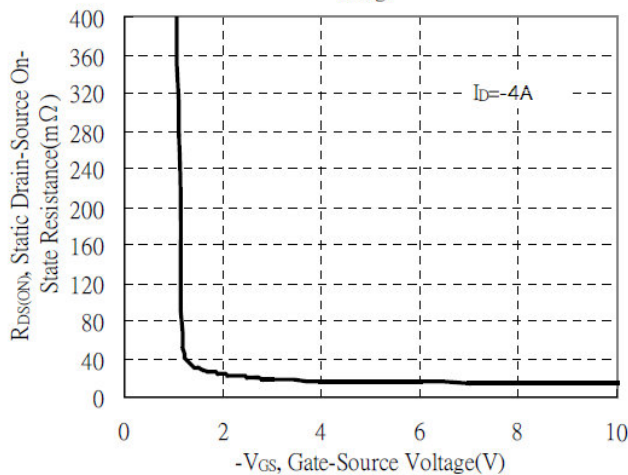
Static Drain-Source On-State resistance vs Drain Current



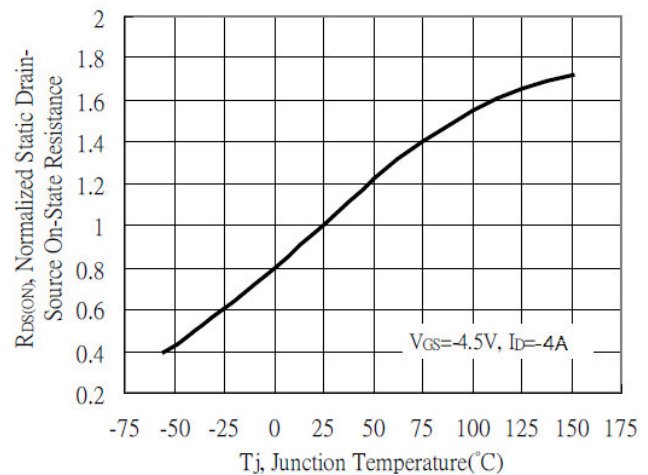
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

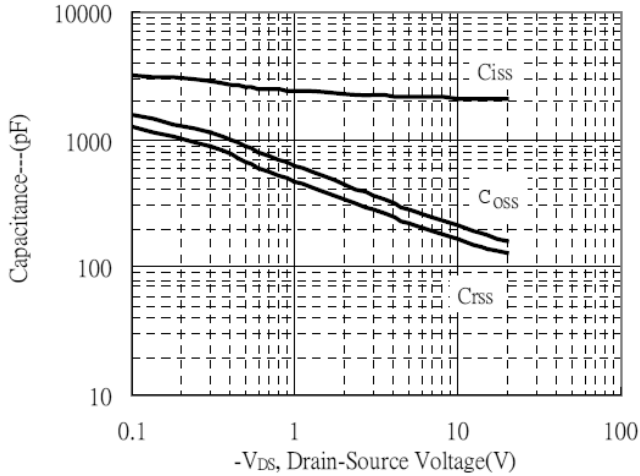


Drain-Source On-State Resistance vs Junction Temperature

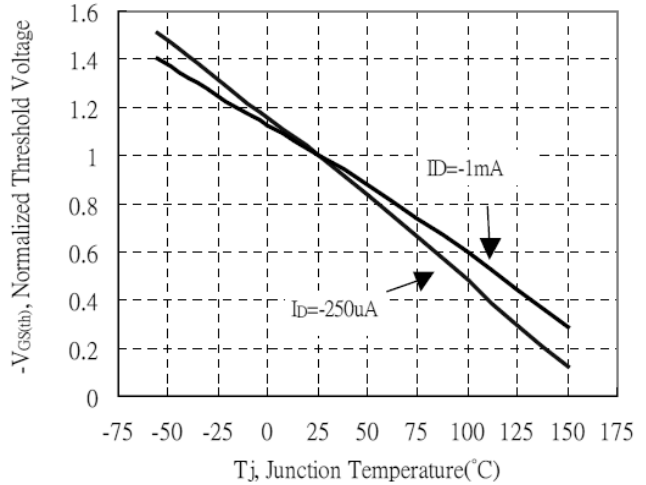


**CHARACTERISTIC CURVES**

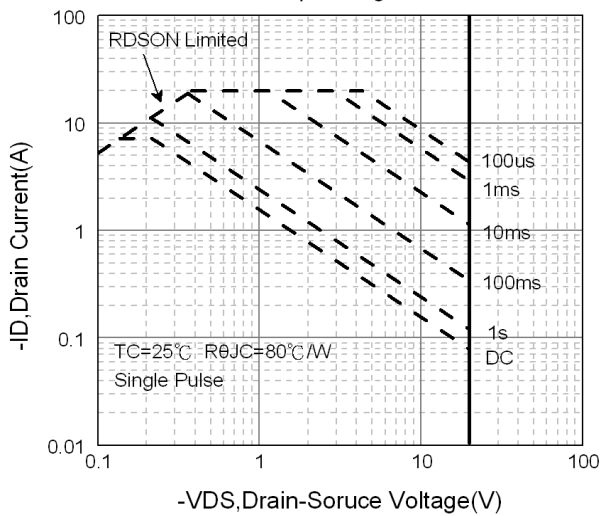
Capacitance vs Drain-to-Source Voltage



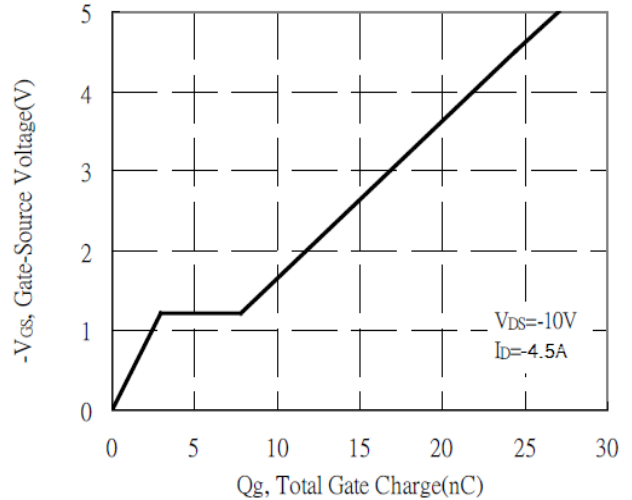
Threshold Voltage vs Junction Temperature



Safe Operating Area



Gate Charge Characteristics



Transient Thermal Response Curves

